

80W - 28V - 1GHz
GOLD METALIZED MULTI-PURPOSE
SILICON DMOS RF FET

FEATURES

- METAL GATE
- EXTRA LOW C_{rss}
- BROAD BAND
- SIMPLE BIAS CIRCUITS
- LOW NOISE
- HIGH GAIN

APPLICATIONS

- HF/VHF/UHF COMMUNICATIONS
from DC to 1GHz

ABSOLUTE MAXIMUM RATINGS

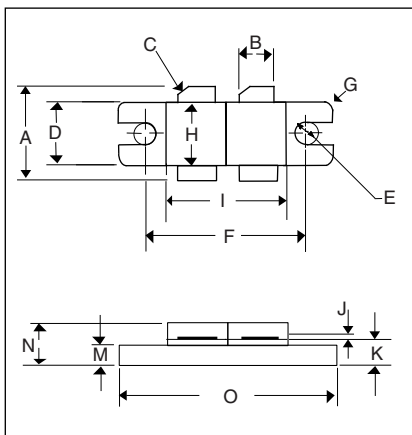
($T_{CASE} = 25^{\circ}C$ unless otherwise stated)

P_D	Power Dissipation	243W
BV_{DSS}	Drain-source breakdown voltage	65V
V_{GS}	Gate-source voltage	$\pm 20V$
I_D	Drain Current	24A
T_{stg}	Storage temperature	-65 to 150°C
T_j	Maximum operating junction temperature	200°C
$R_{\theta j-case}$	Thermal resistance junction-case	Max. .72°C/W

ELECTRICAL CHARACTERISTICS ($T_{CASE} = 25^{\circ}C$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<u>PER SIDE</u>					
BV_{DSS}	Breakdown voltage, drain source $V_{GS}=0$ $I_D=100mA$	65			Vdc
I_{DSS}	Drain leakage current $V_{DS}=28V$ $V_{GS}=0$			3	mAdc
I_{GSS}	Gate leakage current $V_{GS}=20V$ $V_{DS}=0$			1	μ Adc
$V_{GS(th)}$	Gate threshold voltage $I_D=10mA$ $V_{DS}=V_{GS}$	1		7	Vdc
gfs	Transconductance (300 μ s pulse) $V_{DS}=10V$ $I_D=2.4A$	2.4			Mhos
<u>TOTAL DEVICE</u>					
G_{PS}	Common source power gain $P_o=80W$	10			dB
η	Drain efficiency $V_{DS}=28V$ $I_{DQ}=2.4A$	40			%
VSWR	Load mismatch tolerance $f=1GHz$	10:1			
<u>PER SIDE</u>					
C_{iss}	Input capacitance $V_{DS}=0V$ $V_{GS}=-5V$ $f=1MHz$			144	pF
C_{oss}	Output capacitance $V_{DS}=28V$ $V_{GS}=0$ $f=1MHz$			60	pF
C_{rss}	Reverse transfer capacitance $V_{DS}=28V$ $V_{GS}=0$ $f=1MHz$			4.5	pF

DIMENSIONS



DM	Millimeter	TOL	Inches	TOL
A	13.7	MIN	.54	MIN
B	5.72	.13	.225	.005
C	45°	5°	45°	5°
D	9.78	.13	.385	.005
E	1.65R	.13	.065R	.005
F	23.75	.13	.935	.005
G	1.52R	.13	.060R	.005
H	9.53	.13	.375	.005
I	19.18	.26	.755	.010
J	.13	.02	.005	.001
K	2.54	.13	.100	.005
M	1.52	.13	.060	.005
N	4.57	.50	.180	.020
O	30.48	.13	1.200	.005

HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and metal flange is beryllium oxide. Beryllium oxide dust is highly toxic and care must be taken during handling and mounting to avoid damage to this area. THESE DEVICES MUST NEVER BE THROWN AWAY WITH GENERAL INDUSTRIAL OR DOMESTIC WASTE.

U.S. PATENTS 5,121,176 & 5,179,032
GLOBAL PATENTS PENDING

*C201

*PSPICE MODEL FOR POINT NINE RF N-CHANNEL VERTICAL DMOS POWER FET

*May 2004

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*          _____ GATE
*          I  _____ DRAIN
*          I  I  _____ SOURCE
*          I  I  I
.SUBCKT C201  10  20  30
*Cin1,Cin2 & Lin model the input side of the package
Cin1  10   30   0.51p
Lin   10   11   0.44n
Cin2  11   30   0.51p

LG    11   12   0.4n      ;Gate bond wire inductance
CGS   12   13   127.2p    ;Gate-source capacitance
MOS   14   12   13       13  C201  L=0.9U W=0.1308      ;D G S B LEVEL1
JFET  16   13   14       C201                          ;D G S
DBODY 13   16   C201                                       ;P N
LS    13   30   0.15n    ;Source bond wire inductance
CGD   12   16   3.6p     ;Gate-drain feedback capacitance

*Cout1,Cout2 & Lout model the output side of the package
Cout1 16   30   1p
Lout   16   20   0.85n
Cout2 20   30   1p

.MODEL C201 NMOS (VTO=3.52 KP=7.77E-4 LAMBDA=0.0224 RD=0.05 RS=0.22)
.MODEL C201 NJF  (VTO=-5.8 BETA=0.4392 LAMBDA=1.357)
.MODEL C201 D    (CJO=180P RS=0.25 VJ=0.7 M=0.33 BV=70)

.ENDS
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